

TC74VHC393F, TC74VHC393FN, TC74VHC393FT

DUAL BINARY COUNTER

The TC74VHC393 is an advanced high speed CMOS 4-BIT BINARY COUNTER fabricated with silicon gate C²MOS technology.

It achieves the high speed operation similar to equivalent Bipolar Schottky TTL while maintaining the CMOS low power dissipation.

It contains two independent counter circuits in one package, so that counting or frequency division of eight binary bits can be achieved with one IC.

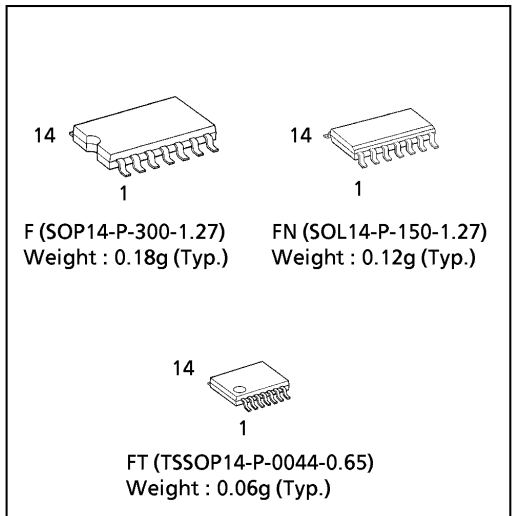
This device changes state on the negative going transition of the $\overline{\text{CLOCK}}$ pulse. The counter can be reset to "0" (QA~QD="L") by a high at the CLEAR input regardless of other inputs.

An input protection circuit ensures that 0 to 5.5V can be applied to the input pins without regard to the supply voltage. This device can be used to interface 5V to 3V systems and two supply systems such as battery back up. This circuit prevents device destruction due to mismatched supply and input voltages.

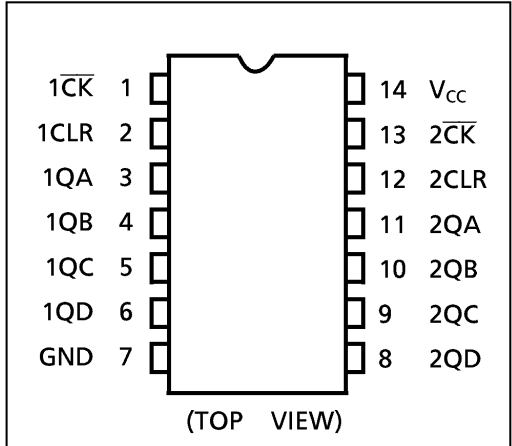
FEATURES :

- High Speed..... $f_{\text{MAX}} = 170\text{MHz}(\text{typ.})$
at $V_{\text{CC}} = 5\text{V}$
- Low Power Dissipation..... $I_{\text{CC}} = 4\mu\text{A}(\text{Max.})$ at $T_a = 25^\circ\text{C}$
- High Noise Immunity..... $V_{\text{NIH}} = V_{\text{NIL}} = 28\% V_{\text{CC}}$ (Min.)
- Power Down Protection is provided on all inputs.
- Balanced Propagation Delays..... $t_{\text{pLH}} \approx t_{\text{pHL}}$
- Wide Operating Voltage Range..... $V_{\text{CC}}(\text{opr}) = 2\text{V} \sim 5.5\text{V}$
- Low Noise..... $V_{\text{OLP}} = 0.8\text{V}$ (Max.)
- Pin and Function Compatible with 74ALS393

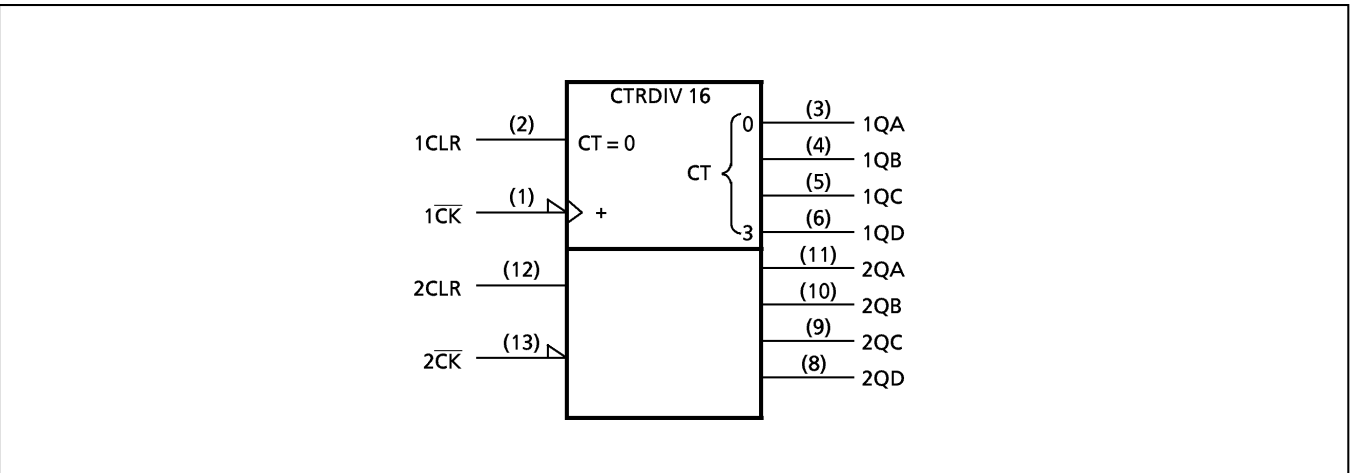
(Note) The JEDEC SOP (FN) is not available in Japan.



PIN ASSIGNMENT





IEC LOGIC SYMBOL



980910EBA2

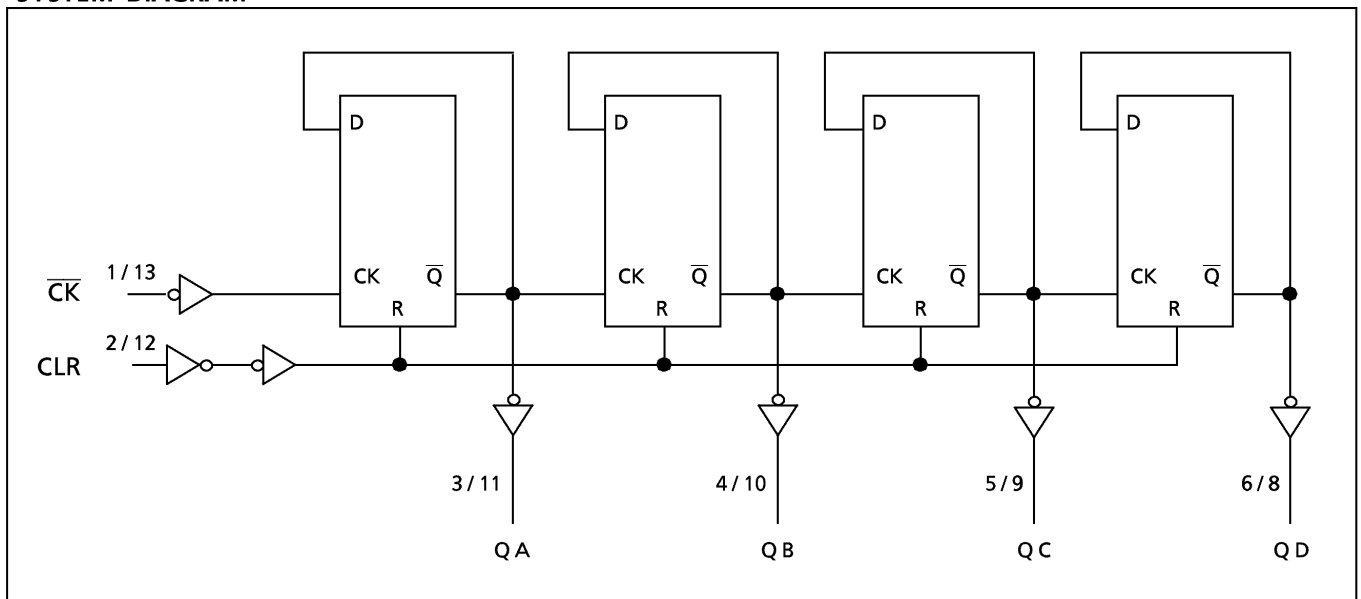
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TRUTH TABLE

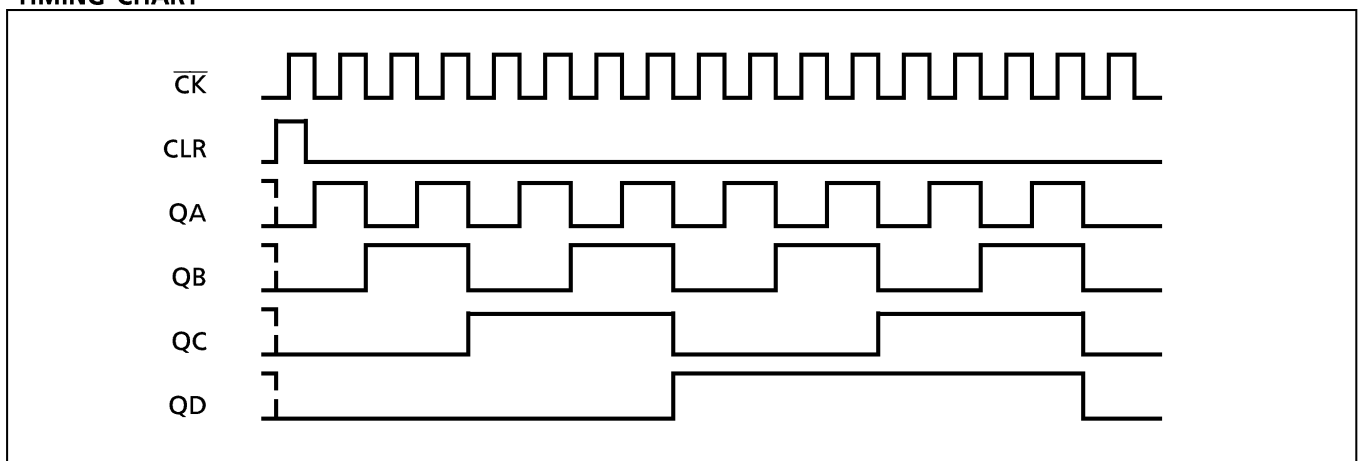
INPUTS		OUTPUTS			
\overline{CK}	CLR	QA	QB	QC	QD
X	H	L	L	L	L
	L	COUNT UP			
	L	NO CHANGE			

X : Don't Care

SYSTEM DIAGRAM



TIMING CHART



980910EBA2'

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ABSOLUTE MAXIMUM RATINGS

PARAMETER	SYMBOL	VALUE	UNIT
Supply Voltage Range	V_{CC}	-0.5~7.0	V
DC Input Voltage	V_{IN}	-0.5~7.0	V
DC Output Voltage	V_{OUT}	-0.5~ $V_{CC} + 0.5$	V
Input Diode Current	I_{IK}	-20	mA
Output Diode Current	I_{OK}	± 20	mA
DC Output Current	I_{OUT}	± 25	mA
DC V_{CC} /Ground Current	I_{CC}	± 75	mA
Power Dissipation	P_D	180	mW
Storage Temperature	T_{stg}	-65~150	$^{\circ}C$

RECOMMENDED OPERATING CONDITIONS

PARAMETER	SYMBOL	VALUE	UNIT
Supply Voltage	V_{CC}	2.0~5.5	V
Input Voltage	V_{IN}	0~5.5	V
Output Voltage	V_{OUT}	0~ V_{CC}	V
Operating Temperature	T_{opr}	-40~85	$^{\circ}C$
Input Rise and Fall Time	dt / dv	0~100 ($V_{CC} = 3.3 \pm 0.3V$) 0~20 ($V_{CC} = 5 \pm 0.5V$)	ns / V

DC ELECTRICAL CHARACTERISTICS

PARAMETER	SYMBOL	TEST CONDITION	V_{CC} (V)	$T_a = 25^{\circ}C$			$T_a = -40 \sim 85^{\circ}C$		UNIT	
				MIN.	TYP.	MAX.	MIN.	MAX.		
High - Level Input Voltage	V_{IH}		2.0	1.50	—	—	1.50	—	V	
			3.0~5.5	$V_{CC} \times 0.7$	—	—	$V_{CC} \times 0.7$	—		
Low - Level Input Voltage	V_{IL}		2.0	—	—	0.50	—	0.50	V	
			3.0~5.5	—	—	$V_{CC} \times 0.3$	—	$V_{CC} \times 0.3$		
High - Level Output Voltage	V_{OH}	$V_{IN} = V_{IH}$ or V_{IL}	$I_{OH} = -50 \mu A$	2.0	1.9	2.0	—	1.9	—	V
				3.0	2.9	3.0	—	2.9	—	
			4.5	4.4	4.5	—	4.4	—		
			$I_{OH} = -4mA$ $I_{OH} = -8mA$	3.0	2.58	—	—	2.48	—	
4.5	3.94	—		—	3.80	—				
Low - Level Output Voltage	V_{OL}	$V_{IN} = V_{IH}$ or V_{IL}	$I_{OL} = 50 \mu A$	2.0	—	0.0	0.1	—	0.1	V
				3.0	—	0.0	0.1	—	0.1	
			4.5	—	0.0	0.1	—	0.1		
			$I_{OL} = 4mA$ $I_{OL} = 8mA$	3.0	—	—	0.36	—	0.44	
4.5	—	—		0.36	—	0.44				
Input Leakage Current	I_{IN}	$V_{IN} = 5.5V$ or GND	0~5.5	—	—	± 0.1	—	± 1.0	μA	
Quiescent Supply Current	I_{CC}	$V_{IN} = V_{CC}$ or GND	5.5	—	—	4.0	—	40.0		

TIMING REQUIREMENTS (Input $t_r = t_f = 3ns$)

PARAMETER	SYMBOL	TEST CONDITION	Ta = 25°C			Ta = -40~85°C	UNIT
			V _{CC} (V)	TYP.	LIMIT	LIMIT	
Minimum Pulse Width (\overline{CK})	$t_{W(H)}$ $t_{W(L)}$		3.3 ± 0.3	—	5.0	5.0	ns
			5.0 ± 0.5	—	5.0	5.0	
Minimum Pulse Width (CLR)	$t_{W(H)}$		3.3 ± 0.3 5.0 ± 0.5	— —	5.0 5.0	5.0 5.0	
Minimum Removal Time	t_{rem}		3.3 ± 0.3 5.0 ± 0.5	— —	5.0 4.0	5.0 4.0	

AC ELECTRICAL CHARACTERISTICS (Input $t_r = t_f = 3ns$)

PARAMETER	SYMBOL	TEST CONDITION		Ta = 25°C			Ta = -40~85°C		UNIT
		V _{CC} (V)	CL (pF)	MIN.	TYP.	MAX.	MIN.	MAX.	
Propagation Delay Time (\overline{CK} - QA)	t_{pLH} t_{pHL}	3.3 ± 0.3	15	—	8.6	13.2	1.0	15.5	ns
			50	—	11.1	16.7	1.0	19.0	
		5.0 ± 0.5	15	—	5.8	8.5	1.0	10.0	
			50	—	7.3	10.5	1.0	12.0	
Propagation Delay Time (\overline{CK} - QB)	t_{pLH} t_{pHL}	3.3 ± 0.3	15	—	10.2	15.8	1.0	18.5	
			50	—	12.7	19.3	1.0	22.0	
		5.0 ± 0.5	15	—	6.8	9.8	1.0	11.5	
			50	—	8.3	11.8	1.0	13.5	
Propagation Delay Time (\overline{CK} - QC)	t_{pLH} t_{pHL}	3.3 ± 0.3	15	—	11.7	18.0	1.0	21.0	
			50	—	14.2	21.5	1.0	24.5	
		5.0 ± 0.5	15	—	7.7	11.2	1.0	13.0	
			50	—	9.2	13.2	1.0	15.0	
Propagation Delay Time (\overline{CK} - QD)	t_{pLH} t_{pHL}	3.3 ± 0.3	15	—	13.0	19.7	1.0	23.0	
			50	—	15.5	23.2	1.0	26.5	
		5.0 ± 0.5	15	—	8.5	12.5	1.0	14.5	
			50	—	10.0	14.5	1.0	16.5	
Propagation Delay Time (CLR - Qn)	t_{pHL}	3.3 ± 0.3	15	—	7.9	12.3	1.0	14.5	
			50	—	10.4	15.8	1.0	18.0	
		5.0 ± 0.5	15	—	5.4	8.1	1.0	9.5	
			50	—	6.9	10.1	1.0	11.5	
Maximum Clock Frequency	f_{MAX}	3.3 ± 0.3	15	75	120	—	65	—	MHZ
			50	45	65	—	35	—	
		5.0 ± 0.5	15	125	170	—	105	—	
			50	85	115	—	75	—	
Input Capacitance	C_{IN}			—	4	10	—	10	pF
Power Dissipation Capacitance	C_{PD}	Note (1)		—	23	—	—	—	

Note(1) C_{PD} is defined as the value of the internal equivalent capacitance which is calculated from the operating current consumption without load.

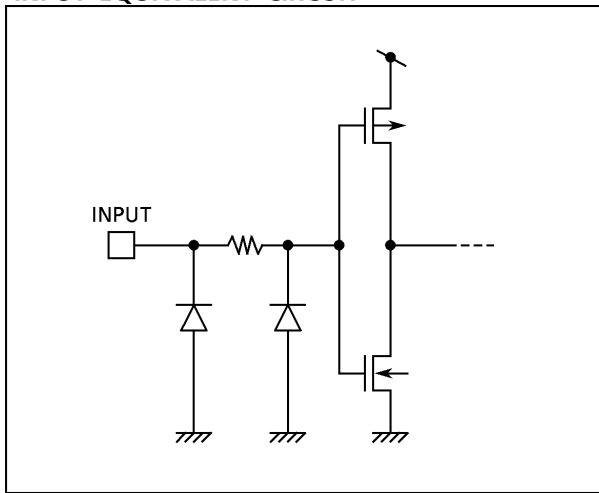
Average operating current can be obtained by the equation :

$$I_{CC(opr.)} = C_{PD} \cdot V_{CC} \cdot f_{IN} + I_{CC} / 2 \text{ (per counter)}$$

NOISE CHARACTERISTICS (Input $t_r = t_f = 3ns$)

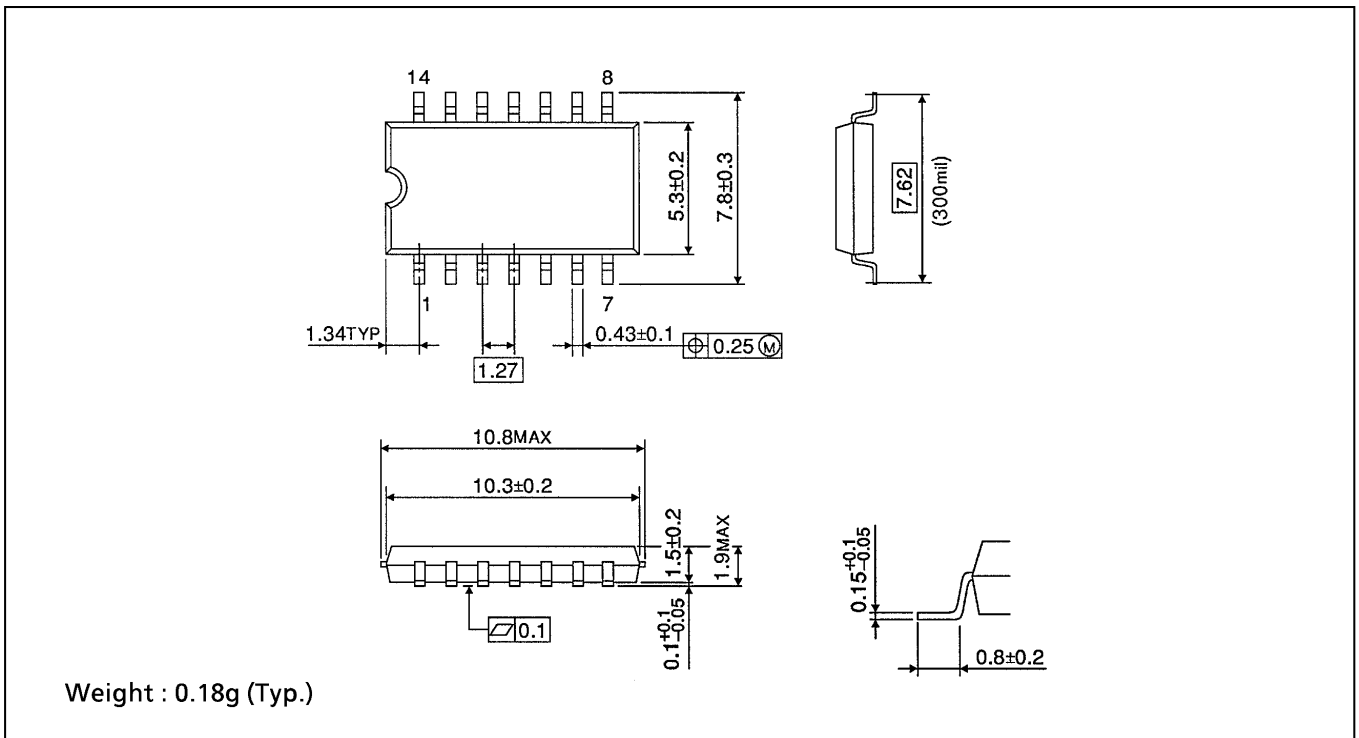
PARAMETER	SYMBOL	TEST CONDITION	Ta = 25°C		UNIT
			V _{CC} (V)	TYP. / MAX.	
Quiet Output Maximum Dynamic V _{OL}	V _{OLP}	C _L = 50pF	5.0	0.5 / 0.8	V
Quiet Output Minimum Dynamic V _{OL}	V _{OLV}	C _L = 50pF	5.0	-0.5 / -0.8	V
Minimum High Level Dynamic Input Voltage	V _{IHD}	C _L = 50pF	5.0	- / 3.5	V
Maximum Low Level Dynamic Input Voltage	V _{ILD}	C _L = 50pF	5.0	- / 1.5	V

INPUT EQUIVALENT CIRCUIT



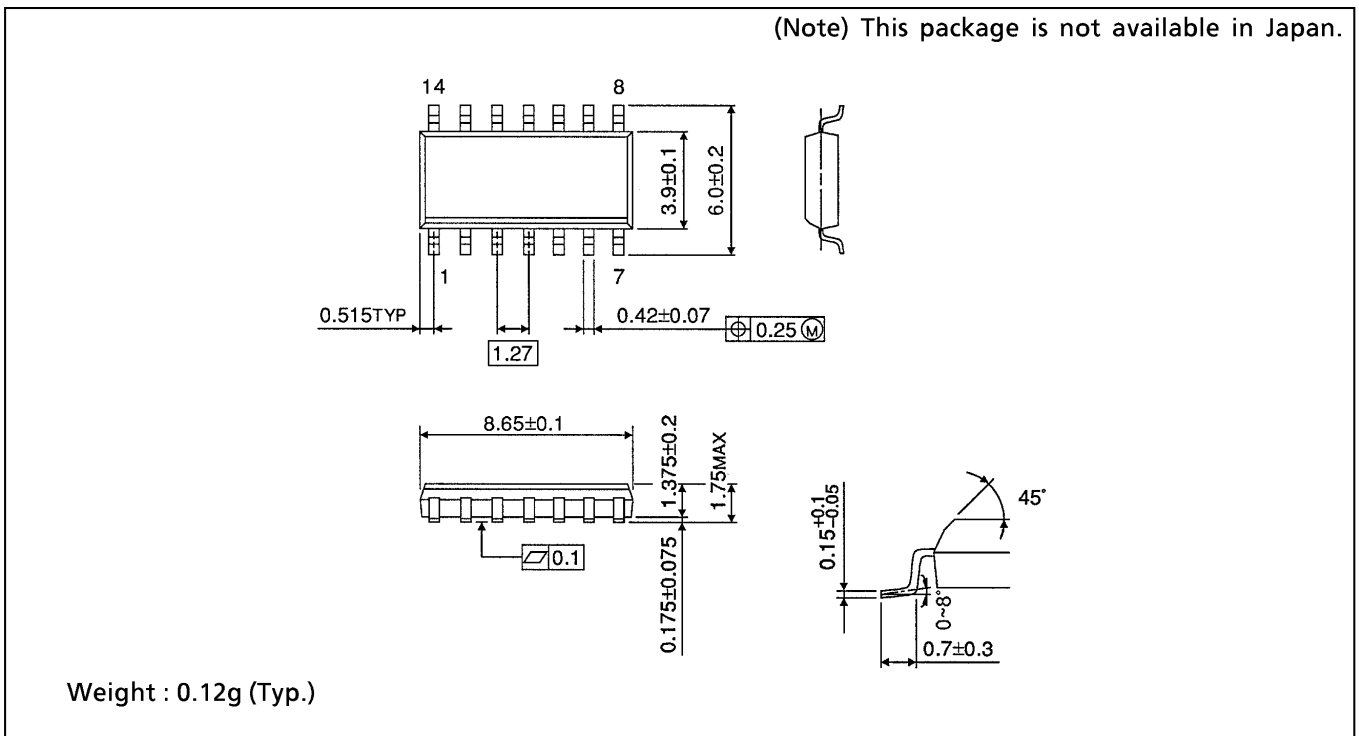
SOP 14PIN (200mil BODY) PACKAGE DIMENSIONS (SOP14-P-300-1.27)

Unit in mm



SOP 14PIN (150mil BODY) PACKAGE DIMENSIONS (SOP14-P-150-1.27)

Unit in mm



TSSOP 14PIN PACKAGE DIMENSIONS (TSSOP14-P-0044-0.65)

Unit in mm

